

C3M0280090J

Silicon Carbide Power MOSFET C3M[™] MOSFET Technology

N-Channel Enhancement Mode

Features

- New C3M SiC MOSFET technology
- High blocking voltage with low On-resistance
- High speed switching with low capacitances
- New low impedance package with driver source
- Fast intrinsic diode with low reverse recovery (Qrr)
- Halogen free, RoHS compliant
- Wide creepage (~7mm) between drain and source

Benefits

- Higher system efficiency
- Reduced cooling requirements
- Increased power density
- Increased system switching frequency

Applications

- Renewable energy
- Lighting

 T_{J} , $\mathsf{T}_{\mathsf{stg}}$

T,

- High voltage DC/DC converters
- Telecom Power Supplies
- Induction Heating

V _{DS}	900 V
l _D @ 25℃	11 A
$R_{DS(on)}$	280 mΩ

Package



Part Number	Package		
C3M0280090J	TO-263-7		

1.6mm (0.063") from case for 10s

Note

Note (1)

Fig. 19

Fig. 22

Fig. 20

Symbol **Test Conditions** Parameter Value Unit V_{DSmax} Drain - Source Voltage 900 ٧ $V_{GS} = 0 V, I_D = 100 \mu A$ V_{GSmax} Gate - Source Voltage -8/+18 ٧ Absolute maximum values V_{GSop} Gate - Source Voltage -4/+15 ٧ Recommended operational values 11 $V_{GS} = 15 V$, $T_{C} = 25^{\circ}C$ I_{D} **Continuous Drain Current** А 7 V_{GS} = 15 V, T_{C} = 100°C **Pulsed Drain Current** 22 А Pulse width t_P limited by T_{imax} I_{D(pulse)} P_{D} **Power Dissipation** 50 W T_c=25°C, T₁ = 150 °C

-55 to

+150

260

°C

°C

Maximum Ratings ($T_c = 25$ °C unless otherwise specified)

Note (1): MOSFET can also safely operate at 0/+15 V

Solder Temperature

Operating Junction and Storage Temperature

CREE C Electrical Characteristics (T_c = 25°C unless otherwise specified)

Symbol	Parameter	Min.	Тур.	Max.	Unit	Test Conditions	Note
V _{(BR)DSS}	Drain-Source Breakdown Voltage	900			V	$V_{GS} = 0 V$, $I_{D} = 100 \mu A$	
$V_{\text{GS(th)}}$	Gate Threshold Voltage	1.8	2.1	3.5	V	V _{DS} = V _{GS} , I _D = 1.2 mA	Fig 11
			1.6		V	V_{DS} = V_{GS} , I_D = 1.2 mA, T_J = 150°C	FIG. 1 1
I _{DSS}	Zero Gate Voltage Drain Current		1	100	μA	V_{DS} = 900 V, V_{GS} = 0 V	
I _{GSS}	Gate-Source Leakage Current		10	250	nA	V_{GS} = 15 V, V_{DS} = 0 V	
D	Drain Source On State Desistance		280	360		V_{GS} = 15 V, I _D = 7.5 A	Fig. 4,
TDS(on)			385		11152	V_{GS} = 15 V, I_{D} = 7.5 A, T_{J} = 150°C	5, 6
C.	Transconductoria		3.6		· ·	V _{DS} = 15 V, I _{DS} = 7.5 A	Fig. 7
9 ^{ts}			3.1		3	V _{DS} = 15 V, I _{DS} = 7.5 A, T _J = 150°C	
C _{iss}	Input Capacitance		150				Fig. 17, 18
Coss	Output Capacitance		20		pF	V_{GS} = 0 V, V_{DS} = 600 V	
Crss	Reverse Transfer Capacitance		2			f = 1 MHz	
E _{oss}	Coss Stored Energy		4.5		μJ	VAC - 23 IIIV	Fig. 16
Eon	Turn-On Switching Energy		19			V_{DS} = 400 V, V_{GS} = -4 V/15 V, I_{D} = 7.5 A,	Fig. 26, 29 Note(3)
E _{OFF}	Turn Off Switching Energy		3.7		μJ	$R_{G(ext)} = 2.5\Omega$, L= 220 µH, T _J = 150°C	
t _{d(on)}	Turn-On Delay Time		10.5		ns	$ V_{\text{DD}} = 400 \text{ V}, \text{V}_{\text{GS}} = -4 \text{ V}/15 \text{ V} $	Fig. 27, 29 Note(3)
tr	Rise Time		6.5				
$t_{d(off)}$	Turn-Off Delay Time		11				
t _f	Fall Time		4				
R _{G(int)}	Internal Gate Resistance		26		Ω	f = 1 MHz, V _{AC} = 25 mV	
Q _{gs}	Gate to Source Charge		2.8			$V_{DS} = 400 \text{ V}$, $V_{GS} = -4 \text{ V}/15 \text{ V}$	Fig. 12
Q_{gd}	Gate to Drain Charge		3.4		nC	$I_D = 7.5 \text{ A}$	
Qg	Total Gate Charge		9.5			Per IEC60747-8-4 pg 21	

Reverse Diode Characteristics (T $_{\rm c}$ = 25 $^{\circ}{\rm C}$ unless otherwise specified)

Symbol	Parameter	Тур.	Max.	Unit	Test Conditions	Note
V _{SD}	Diode Forward Voltage	4.8		V	$V_{_{\rm GS}}$ = -4 V, I $_{_{\rm SD}}$ = 4 A	Fia. 8. 9.
		4.4		V	$V_{_{GS}}$ = -4 V, I $_{_{SD}}$ = 4 A, T $_{_{J}}$ = 150 °C	10 '
Is	Continuous Diode Forward Current		9	А	V _{GS} = -4 V	Note (2)
I _{S, pulse}	Diode pulse Current		22	А	$V_{_{GS}}$ = -4 V, pulse width t_P limited by T _{jmax}	Note (2)
t _{rr}	Reverse Recover time	20		ns		
Q _{rr}	Reverse Recovery Charge	47		nC	V _{cs} = -4 V, I _{sp} = 7.5 A, V _R = 400 V dif/dt = 600 A/µs, T _J = 150 °C	Note (2)
I _{rrm}	Peak Reverse Recovery Current	3.4		А	-	

Note (2): When using SiC Body Diode the maximum recommended V_{GS} = -4V

Thermal Characteristics

Symbol	Parameter	Max.	Unit	Test Conditions	Note
R _{eJC}	Thermal Resistance from Junction to Case	2.5			F: 01
R _{0JA}	Thermal Resistance From Junction to Ambient	40	°C/W		Fig. 21



Typical Performance



Figure 3. Output Characteristics T_J = 150 °C











3



Typical Performance



Figure 11. Threshold Voltage vs. Temperature



4

CREE ᆃ

Typical Performance



Figure 13. 3rd Quadrant Characteristic at -55 °C



Figure 15. 3rd Quadrant Characteristic at 150 °C



Figure 17. Capacitances vs. Drain-Source Voltage (0 - 200V)



Figure 14. 3rd Quadrant Characteristic at 25 °C



Figure 16. Output Capacitor Stored Energy





CREE ᆃ

Typical Performance







6



Typical Performance



Figure 25. Clamped Inductive Switching Energy vs. $R_{G(ext)}$



Figure 27. Switching Times vs. $R_{G(ext)}$



Figure 26. Clamped Inductive Switching Energy vs. Temperature



Figure 28. Switching Times Definition



Test Circuit Schematic



Figure 29. Clamped Inductive Switching Test Circuit

Note (3): Turn-off and Turn-on switching energy and timing values measured using SiC MOSFET Body Diode as shown above.



Package Dimensions

TO-263-7







Notes

RoHS Compliance

The levels of RoHS restricted materials in this product are below the maximum concentration values (also referred to as the threshold limits) permitted for such substances, or are used in an exempted application, in accordance with EU Directive 2011/65/ EC (RoHS2), as implemented January 2, 2013. RoHS Declarations for this product can be obtained from your Cree representative or from the Product Documentation sections of www.cree.com.

REACh Compliance

REACh substances of high concern (SVHCs) information is available for this product. Since the European Chemical Agency (ECHA) has published notice of their intent to frequently revise the SVHC listing for the foreseeable future, please contact a Cree representative to insure you get the most up-to-date REACh SVHC Declaration. REACh banned substance information (REACh Article 67) is also available upon request.

• This product has not been designed or tested for use in, and is not intended for use in, applications implanted into the human body nor in applications in which failure of the product could lead to death, personal injury or property damage, including but not limited to equipment used in the operation of nuclear facilities, life-support machines, cardiac defibrillators or similar emergency medical equipment, aircraft navigation or communication or control systems, air traffic control systems.

Related Links

- C2M PSPICE Models: http://wolfspeed.com/power/tools-and-support
- SiC MOSFET Isolated Gate Driver reference design: http://wolfspeed.com/power/tools-and-support
- SiC MOSFET Evaluation Board: http://wolfspeed.com/power/tools-and-support

Copyright © 2018 Cree, Inc. All rights reserved. The information in this document is subject to change without notice. Cree, the Cree logo, and Zero Recovery are registered trademarks of Cree, Inc. Cree, Inc. 4600 Silicon Drive Durham, NC 27703 USA Tel: +1.919.313.5300 Fax: +1.919.313.5451 www.cree.com/power

X-ON Electronics

Largest Supplier of Electrical and Electronic Components

Click to view similar products for MOSFET category:

Click to view products by Wolfspeed manufacturer:

Other Similar products are found below :

614233C 648584F IRFD120 JANTX2N5237 2N7000 FCA20N60_F109 FDZ595PZ 2SK2545(Q,T) 405094E 423220D TPCC8103,L1Q(CM MIC4420CM-TR VN1206L 614234A 715780A NTNS3166NZT5G SSM6J414TU,LF(T 751625C IPS70R2K0CEAKMA1 BUK954R8-60E DMN3404LQ-7 NTE6400 SQJ402EP-T1-GE3 2SK2614(TE16L1,Q) 2N7002KW-FAI DMN1017UCP3-7 EFC2J004NUZTDG ECH8691-TL-W FCAB21350L1 P85W28HP2F-7071 DMN1053UCP4-7 NTE221 NTE2384 NTE2903 NTE2941 NTE2945 NTE2946 NTE2960 NTE2967 NTE2969 NTE2976 NTE455 NTE6400A NTE2910 NTE2916 NTE2956 NTE2911 US6M2GTR TK10A80W,S4X(S SSM6P69NU,LF